

Notice of References Cited

Application/Control No.

10/786,164

Applicant(s)/Patent Under
Reexamination
BEAN ET AL.

Examiner

Alvin C. Chin-Shue

Art Unit

3634

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-3,735,876	05-1973	Brownell et al.	212/276
*	B	US-5,257,177	10-1993	Bach et al.	700/61
*	C	US-5,903,988	05-1999	Tochizawa et al.	37/348
	D	US-			
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	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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